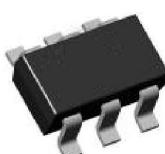
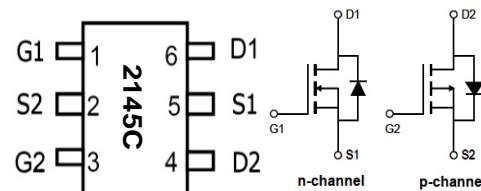


### Main Product Characteristics

$V_{(BR)DSS}$	20V	-20V
$R_{DS(ON)}$ (Typ.)	38mΩ	68mΩ
$I_D$	4.8A	-2.9A



TSOP-6



Marking and Pin  
Assignment

Schematic Diagram

### Features and Benefits

- Advanced trench MOSFET process technology
- Designed for load switching and battery protection applications
- 150°C operating temperature



### Description

The SSF2145CH6 utilizes the latest techniques to achieve high cell density and low on-resistance. These features make this device extremely efficient and reliable for use in high efficiency switch mode power supply and a wide variety of other applications.

### Absolute Max Ratings

Symbol	Parameter	Max.		Unit
		N-channel	P-channel	
$I_D$ @ $T_C = 25^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 4.5\text{V}$ ①	4.8	-2.9	A
$I_D$ @ $T_C = 100^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 4.5\text{V}$ ①	3.9	-2.4	
$I_{DM}$	Pulsed Drain Current②	17	-11	
$P_D$ @ $T_C = 25^\circ\text{C}$	Power Dissipation③	1.7	1.7	W
$V_{DS}$	Drain-Source Voltage	20	-20	V
$V_{GS}$	Gate-to-Source Voltage	$\pm 8$	$\pm 8$	V
$T_J, T_{STG}$	Operating Junction and Storage Temperature Range	-55 to + 150	-55 to + 150	°C

### Thermal Resistance

Symbol	Characteristics	Typ.	Max.		Unit
			N-channel	P-channel	
$R_{\theta JA}$	Junction-to-Ambient ( $t \leq 10\text{s}$ ) ④	—	76	114	°C/W
	Junction-to-Ambient (PCB mounted, steady-state) ④	—	53	53	°C/W

### Electrical Characteristics ( $T_A=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter		Min.	Typ.	Max.	Unit	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	N-Channel	20	—	—	V	$V_{GS} = 0\text{V}, I_D = 250\mu\text{A}$
			22	—	—		$T_J = 125^\circ\text{C}$
	P-Channel		-20	—	—		$V_{GS} = 0\text{V}, I_D = -250\mu\text{A}$
			-22	—	—		$T_J = 125^\circ\text{C}$
$R_{DS(\text{ON})}$	Static Drain-to-Source On-Resistance	N-Channel	—	38	55	mΩ	$V_{GS}=4.5\text{V}, I_D = 3.6\text{A}$
		P-Channel	—	68	80		$V_{GS}=-4.5\text{V}, I_D = -3\text{A}$
		N-Channel	—	64	75		$V_{GS}=2.5\text{V}, I_D = 3.1\text{A}$
		P-Channel	—	89	100		$V_{GS}=-3.5\text{V}, I_D = -2\text{A}$
		N-Channel	—	55	63		$V_{GS}=1.8\text{V}, I_D = 2\text{A}$
		P-Channel	—	129	148		$V_{GS}=-1.8\text{V}, I_D = -1\text{A}$
$V_{GS(\text{th})}$	Gate Threshold Voltage	N-Channel	0.4	0.72	1	V	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$
		P-Channel	-0.4	-0.56	-1		$T_J = 125^\circ\text{C}$
		N-Channel	0.4	0.78	1		$V_{DS} = V_{GS}, I_D = -250\mu\text{A}$
		P-Channel	-0.4	-0.66	-1		$T_J = 125^\circ\text{C}$
$I_{DSS}$	Drain-to-Source Leakage Current	N-Channel	—	—	1	μA	$V_{DS} = 20\text{V}, V_{GS} = 0\text{V}$
		P-Channel	—	—	-1		$V_{DS} = -20\text{V}, V_{GS} = 0\text{V}$
$I_{GSS}$	Gate-to-Source Forward Leakage	N-Channel	—	—	100	nA	$V_{GS} = 8\text{V}$
		N-Channel	—	—	100		$V_{GS} = -8\text{V}$
		P-Channel	—	—	-100		$V_{GS} = 8\text{V}$
		P-Channel	—	—	-100		$V_{GS} = -8\text{V}$
C <sub>iss</sub>	Input Capacitance	N-Channel	—	348	420	pF	$V_{GS} = 0\text{V}, V_{DS} = 10\text{V}, f = 1.0\text{MHz}$
C <sub>oss</sub>	Output Capacitance	N-Channel	—	58	70		
Cr <sub>ss</sub>	Reverse Transfer Capacitance	N-Channel	—	32	39		
C <sub>iss</sub>	Input Capacitance	P-Channel	—	519	622		
C <sub>oss</sub>	Output Capacitance	P-Channel	—	75	90		$V_{GS} = 0\text{V}, V_{DS} = -10\text{V}, f = 1.0\text{MHz}$
Cr <sub>ss</sub>	Reverse Transfer Capacitance	P-Channel	—	58	70		
t <sub>d(on)</sub>	Turn-On Delay Time	N-Channel	—	5	12	nS	$V_{DD}=10\text{V}, R_L = 2.8 \Omega$ $V_{GS}=4.5\text{V}, R_{GEN}=6\Omega, I_D=3.6\text{A}$
t <sub>r</sub>	Rise Time	N-Channel	—	10	30		
t <sub>d(off)</sub>	Turn-Off Delay Time	N-Channel	—	10	30		
t <sub>f</sub>	Fall Time	N-Channel	—	7	28		
t <sub>d(on)</sub>	Turn-On Delay Time	P-Channel	—	13.6	27.2	nS	$V_{DD}=-10\text{V}, I_D=-3\text{A}$ $V_{GS}=-4.5\text{V}, R_{GEN}=3\Omega$
t <sub>r</sub>	Rise Time	P-Channel	—	8.6	17.2		
t <sub>d(off)</sub>	Turn-Off Delay Time	P-Channel	—	73.6	147.2		
t <sub>f</sub>	Fall Time	P-Channel	—	34.6	69.2		

## Source-Drain Ratings and Characteristics

Symbol	Parameter		Min.	Typ.	Max.	Unit	Conditions
$I_S$	Continuous Source Current (Body Diode)	N-Channel	—	—	4.8	A	MOSFET symbol showing the integral reverse p-n junction diode.
		P-Channel	—	—	-2.9		
$I_{SM}$	Pulsed Source Current (Body Diode)	N-Channel	—	—	17	A	
		P-Channel	—	—	-11		
$V_{SD}$	Diode Forward Voltage	N-Channel	—	0.69	1.2	V	$I_S=0.94A, V_{GS}=0V$
		P-Channel	—	-0.72	-1.2		$I_S=-0.75A, V_{GS}=0V$

Notes:

- 1.The maximum current rating is limited by bond-wires.
- 2.Repetitive rating; pulse width limited by max. junction temperature.
- 3.The power dissipation  $P_D$  is based on max. junction temperature, using junction-to-ambient thermal resistance.
- 4.The value of  $R_{\theta JA}$  is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ C$

## Typical Electrical and Thermal Characteristics

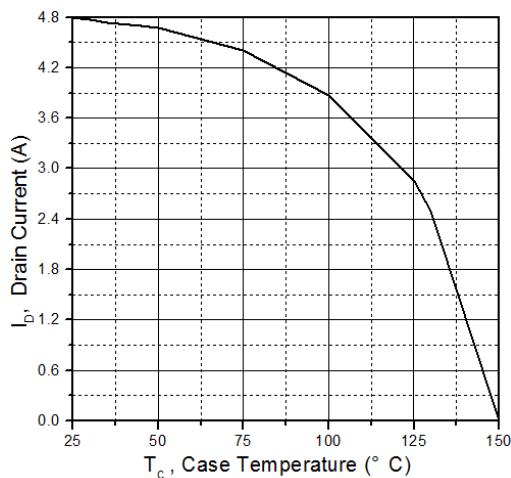


Figure 1. Maximum Drain Current Vs. Case Temperature (N-Channel)

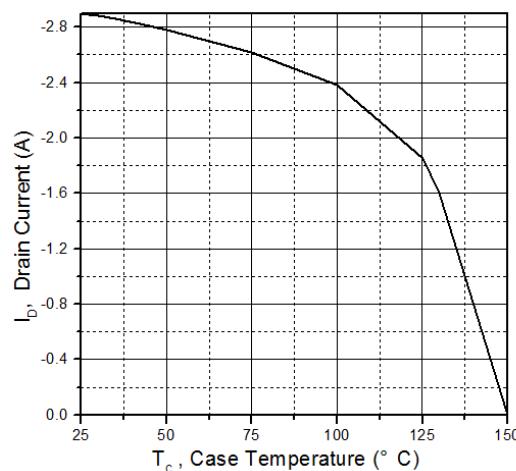


Figure 2. Maximum Drain Current Vs. Case Temperature (P-Channel)

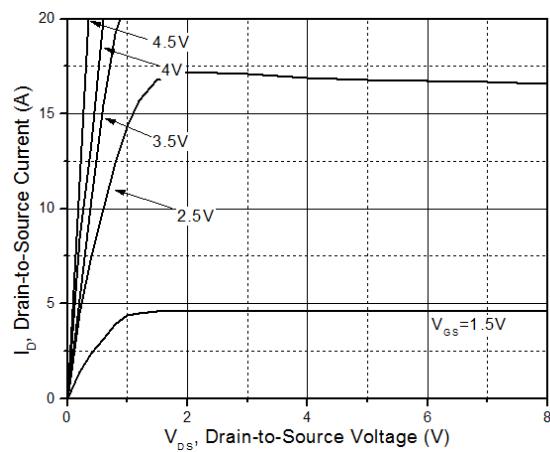


Figure 3. Typical Output Characteristics (N-Channel)

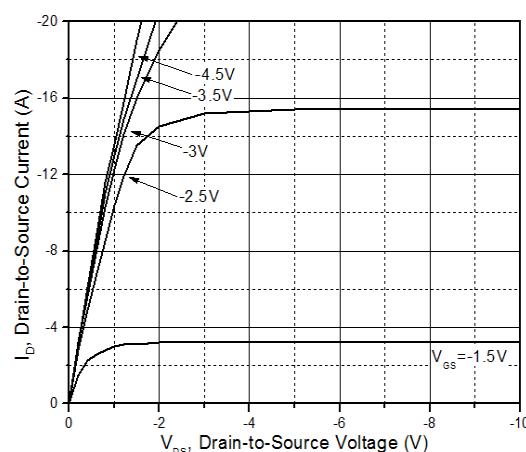


Figure 4. Typical Output Characteristics (P-Channel)

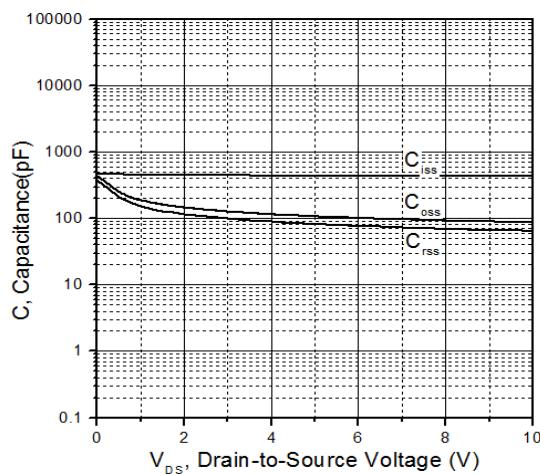


Figure 5. Typical Capacitance Vs. Drain-to-Source Voltage (N-Channel)

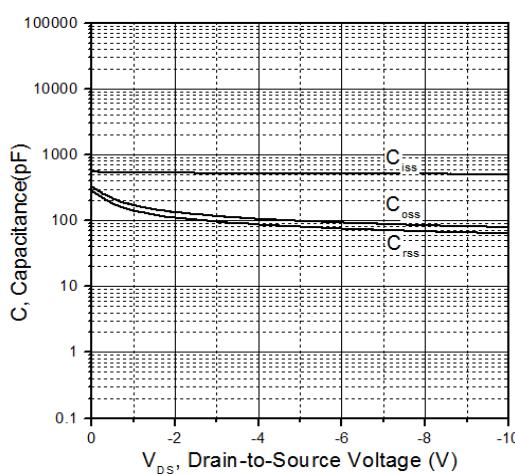
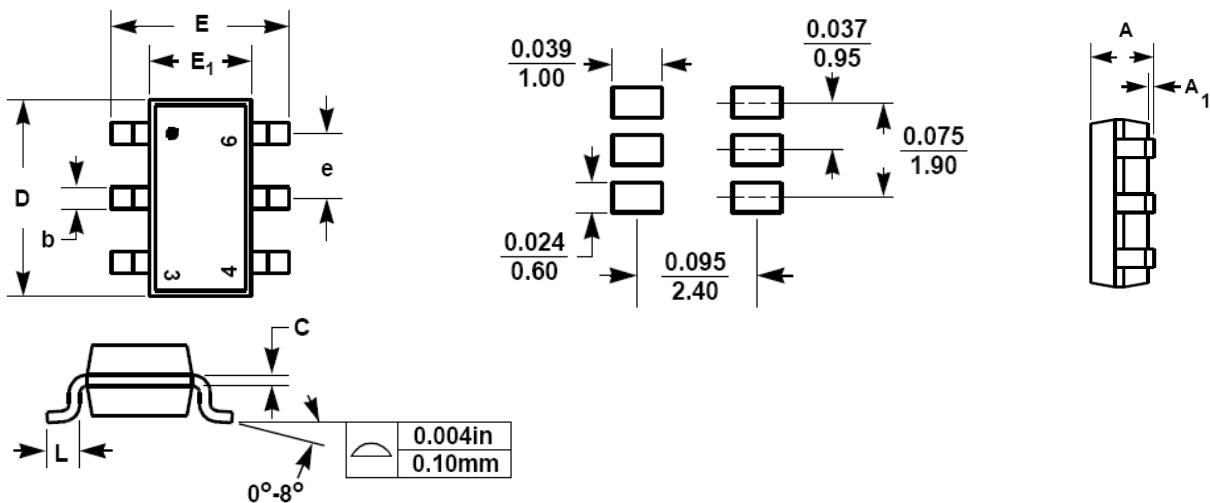


Figure 6. Typical Capacitance Vs. Drain-to-Source Voltage (P-Channel)

### Mechanical Data: TSOP-6



SYMBOL	Millimeters	
	MIN	MAX
A	0.90	1.30
A1	0.10	
b	0.30	0.50
c	0.08	0.20
D	2.80	3.10
E	2.60	3.00
E1	1.50	1.70
e	0.95 BSC	
L	0.35	0.55

#### Notes:

1. Dimensions are inclusive of plating
2. Package body sizes exclude mold flash and gate burrs. Mold flash at the non-lead sides should be less than 6 mils
3. Dimension L is measured in gauge plane.
4. Controlling dimension is millimeter, converted inch dimensions are not necessarily exact.

### Order Information

Device	Package	Marking	Carrier	Quantity
SSF2145CH6	TSOP-6	2145C	Tape & Reel	3,000pcs / Reel